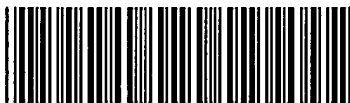


Search Notes

Application/Control No.

10/645,412

Examiner

Patricia Leith

Applicant(s)/Patent under
Reexamination

HON ET AL.

Art Unit

1654

SEARCHED

Class	Subclass	Date	Examiner
updated	all	6/9/2005	PL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated all	6/9/2005	PL